

U.S. PATENT DOCUMENTS

Exam. Initial	Document Number	Date	Name	Class	Sub Class	Filing Date
RP	09/570,697	,	TAKEUCHI et al.			05/12/2000
		/ ; ·			REC	EIVED
					MAR 1	5 2002
				Te	chnology	Center 2800
						2000

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Sub Class	Translation	Abstract

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages Etc.)

Examiner	RAYMOND PHAN	Date Considered 10-8-03

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